

Laboratori Nazionali di Frascati

LNF-87/64

C. Coluzza, P. Perfetti, C. Quaresima, M. Capozzi and G. Fortunat:
FANO RESONANCE IN AMORPHOUS SILICON NITRIDE

Estratto da:
SIF - Conf. Proc. "Synchrotron Radiation at Frascati" Vol. 5, 195 (1986)

Servizio Documentazione
dei Laboratori Nazionali di Frascati
P.O. Box, 13 - 00044 Frascati (Italy)

FANO RESONANCE IN AMORPHOUS SILICON NITRIDE

C.Coluzza

Dip. di Fisica, Università "La Sapienza" di Roma, Roma, Italy

P.Perfetti, C.Quaresima, M.Capozzi

Istituto di Struttura della Materia del CNR, Frascati, Italy

G.Fortunato

Istituto di Elettronica dello Stato Solido del CNR,

Via Cineto Romano 42, 00156 Roma, Italy

Resonant photoemission is becoming a very important experimental method in the study of localized states present in the band structure of metals and semiconductors⁽¹⁾. A resonant process is the enhancement of the primary photoelectron yield when the photon energy coincides with the transition energy from a core level to empty localized states. At these photon energies there could be more than one final state configuration to which the system can be excited upon absorption of a photon. It is essentially the interaction among these different final state configurations that causes the resonant enhancement⁽¹⁾.

The enhanced photoemission intensity vs the photon energy exhibits the characteristic line profile predicted by Fano⁽²⁾. Photoemission spectra were taken in Constant Initial State (CIS) mode. The chosen initial state was near 2 eV binding energy and a resonant feature with a maximum near $h\nu=21$ eV is shown in Fig. 1.

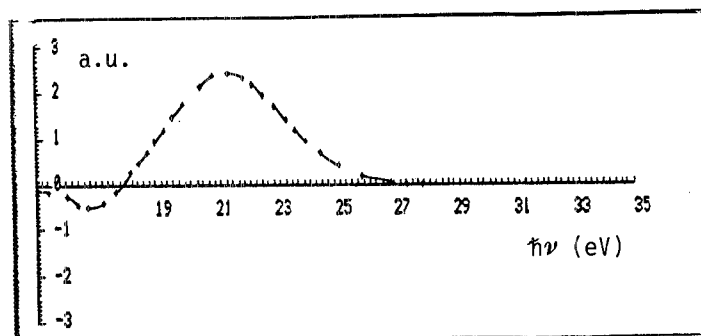


Fig. 1 - Fano-line-shape of the CIS spectrum.

The curve is the amplified difference of the CIS spectrum and a quadratic non resonant background to better evidence the resonant behavior. Since the N2s core level is 18.2 eV below the top of the valence band⁽³⁾ and the energy gap of silicon nitride is 5.4 eV⁽⁴⁾, the resonant feature of Fig. 1 near 21 eV places the final LS state of the discrete transition well into the energy gap. The resonant peak of Fig. 1 is more likely due to transitions from N2s core levels to the above p-like conduction band states and the excitonic coupling is responsible for the localization and for the energy shift of the optical transition (2.6 eV).

References:

- (1) P.Perfetti, Intern. School "Enrico Fermi" on Excited States Spectroscopy in Solids, Varenna, July 9-19, 1985, in press, and references therein.
- (2) U.Fano, Phys. Rev. 124, 1866 (1961).
- (3) C.Coluzza, G.Fortunato, C.Quaresima, M.Capozi and P.Perfetti, Proceedings of the 11th Intern. Conf. on Amorphous and Liquid Semiconductors, Roma, September 2-6, 1985.
- (4) L.Ley, R.Kaercher and R.L.Johnson, Phys. Rev. B53, 720 (1984).